

EVALUATING DATA HANDLING DEVICES BY MEANS OF A MARKER IMPURITY

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**Related Applications**

5           This application claims priority of United States provisional application Serial  
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**Field of the Invention**

10           This application relates generally to data handling devices and more particularly to  
evaluating the reliability thereof.

**Background of the Invention**

15           Electromechanical data handling and storage devices can be susceptible to data loss  
or corruption due to external contaminants, or impurities, interfering with their operation.  
Typical devices well known in the industry include but are not limited to "Winchester"  
style disc drives, tape drives, and optical storage devices. Such devices use a magnetizable  
medium coated on a supporting substrate where information is written and stored coupled  
20 with a mechanism(s) used to write and or to retrieve that information stored on the  
medium. Such data handling devices commonly contain these components in addition to  
others within a chamber. These data handling devices are often designed with a variety of  
safeguards to help prevent impurities from coming into contact and damaging the  
magnetizable medium resulting in data loss. Such safeguards can include any one or  
25 combination of specialized materials, lubricants, filters, seals and pumps. However, these  
preventative solutions to guard against impurities have had only limited success.

Reliable data handling and storage is a critical parameter used to gage the  
successfulness of data handling devices. The implications of even minor data loss in data

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handling devices can be detrimental to the salability of that device in addition to further financial damage to a manufacturer's reputation due to frustrated end users. As a consequence, sample lots of these devices are generally tested in a variety of normal to accelerated functionality operations to measure their level of reliability. If damage occurs to either the magnetizable medium or the mechanism used to write or retrieve information, the device will have effectively lost data and in some circumstances, lost data in a specific and identifiable location. In some instances, environments are artificially generated containing dispersed impurities at a designed concentration to accelerate these types of data loss failures.

Dispersing commonly encountered impurities, often in the form of particulates, in concentrated levels around data handling devices have been used by people skilled in the art to help understand the data integrity relative to the impurities. Further, procedures have been created to test the effectiveness of data handling and storage in an artificially generated commonly encountered impurity rich environment. These procedures and tests can give insight as to how well the device can cope with the impurity used in order to enhance the design to safeguard around such an impurity. These procedures can also lead to testing of competitive devices in order to formulate a level of comparative performance.

Accelerated impurity enriched reliability testing of data handling devices can provide clues to the damage resistance of magnetizable medium or the components that transfer data thereon. There are a multitude of factors that dramatically change the robustness to particle type impurities inherent in the engineering designs of these devices, as touched upon earlier. There are also varied responses within the device due to particle type(s) and size(s). As a result, it is extremely difficult to decouple the positive and negative contributions of various designs and components when interacting with commonly encountered particulate impurities between data handling devices.

Among the designs and components that is currently difficult to figure out in data handling and storage devices is the ability to seal the device from these external particulate impurities. Most of these devices are designed to be sealed from particulate impurities external to the devices. By this it is meant that a sealed chamber herein is a chamber

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having a barrier, a gap in the chamber covered by a seal. A seal acts as a barrier capable of preventing the transfer of material, in this case a particle larger than the minimal acceptable size. A seal could include a gasket, filter, or simply a gap in the chamber below the minimal acceptable area. Because the current state of the art testing procedures have limited repeatability in terms of acceptably testing the true effectiveness of the seal of a device's chamber, an improved test that is far more decisive and informative is needed for the development of a more competitive and superior designed data handling and storage device.

### Summary of the Invention

The present invention is a method for evaluating a multiplicity of data handling devices each having a sealed chamber with several interior surfaces. It uses an impurity chamber containing thousands of dispersed gas-borne particles that each contain a marker impurity that is substantially absent from all of the interior surfaces of at least one of the devices. That device is tested for reliability using the marker impurity.

In a preferred embodiment, the device has a chamber part of which (the "cavity") is adjacent to a portion of the device's housing that includes an imperfect seal. The seal is exposed to an impurity chamber at a pressure higher than that of the cavity for at least a day. The multiplicity of devices is evaluated based on an indication of whether the marker impurity was present in the selected device(s) in an amount exceeding a predetermined threshold.

Additional features and benefits will become apparent upon reviewing the following figures and their accompanying detailed description.

### **Brief Description of the Drawings**

Fig. 1 shows a very detailed method embodiment of the present invention.

5 Fig. 2 shows an even more detailed method for using a single-device testing method like that of Fig. 1.

Fig. 3 shows a handling device having a housing with a sealed portion adjacent an impurity chamber, the portion including a porous filter or other imperfect seal.

10 Fig. 4 shows a prototype apparatus suitable for performing a method like those of Figs. 1&2.

Fig. 5 shows a partially exploded view of the disc drive under test in Fig. 4.

### **Detailed Description**

Although the examples below show more than enough detail to allow those skilled in the art to practice the present invention, subject matter regarded as the invention is broader than any single example below. The scope of the present invention is distinctly defined, however, in the claims at the end of this document.

20 Numerous aspects of data storage device technology that are not a part of the present invention (or are well known in the art) are omitted for brevity, avoiding needless distractions from the essence of the present invention. For example, this document does not include much detail about methods for grinding or handling particulate materials or about performing effective SEM photography or spectral analysis. Also omitted are specific methods for materials selection, leak-testing or other aspects of data handling  
25 device manufacturing or operation.

Definitions and clarifications of certain terms are provided in conjunction with the descriptions below, all consistent with common usage in the art but some described with greater specificity. For example, "evaluating" a group is any process of assigning a quality indication, action selection, or similar text or numerical value to the group based upon a

detected attribute of the group or a sample of it. A derived value is "based on" another value (the "original" value) if it can depend on the original value. More technically, such a derived value will depend on the original value for some values of other factors upon which the derived value depends. Note that the original value need not be prominent  
5 among such factors. A lamp's functionality is "based on" its power switch position, for example, even though this dependence is only manifested when the lamp is plugged in.)

When measuring a quantity that cannot be negative, such as an rate or similar quantification of an impurity, a threshold is "effectively zero" if the measurement mechanism cannot distinguish a measured level below the threshold from zero.  
10 Alternatively, an excessive level of an impurity present may be indicated in a manner that provides a significant margin of thousands of particles or more inside each selected device without indicating impurities exceed the allowable threshold. Moreover, an "excessive impurities" indication may correlate only crudely with an impurity amount. For example, the indication may result as an inference from an excessive number of new errors formed in a device as it operates.

A marker impurity is "substantially absent" from the interior surfaces of a device if the surfaces themselves are not made of a detectable amount of the impurity and if fewer than 50 particles containing a detectable amount of the material rest on the interior surfaces. For a self-cleaning, sealed device in which outgassing and particulate  
20 contamination are controlled, any material not used in manufacturing components of the device should be assumed to meet this condition.

Turning now to **Fig. 1**, there is shown a very detailed method **100** of the present invention comprising steps **105** through **160**. Some or all of a production lot of disc drives is sampled, and the samples are leak tested. The leak rate values within a predetermined  
25 specification are averaged, and a disc drive leaking faster than the average rate is selected **110**. It should be emphasized that step **110** is optional, and that any similarly-manufactured set of devices sensitive to dust contamination can be selected in any way, so long as the selected set includes at least one cavity and an adjacent sealed housing portion.

This point should be clear from the claims as granted, which articulate the metes and bounds of the present invention in its various characterizations.

Continuing the detailed method **100** of **Fig. 1**, about 5 grams of a material substantially absent from the disc drive's internal surfaces (e.g. diamond or molybdenum) is ground into dust particles, most being within an order of magnitude greater in length than the median track width (of the tracks in the disc drive) **120**. (A particle's "length" or "diameter" refers to its largest dimension.) Most preferably, the "marker impurity" is a mixture of diamond particles, luminescent dye, and radium.

A particle that is very hard (i.e. at least 10% harder than a data storage coating surface material) such as diamond is desirable because it facilitates damage to a data storage medium, transducer head, or other parts that move in precise, close proximity. This damage is relatively easy to detect in many dust-sensitive devices, as will be appreciated by one of ordinary skill in the art. A luminescent or other dye having distinctive optical properties likewise facilitates detection by optical means, especially in a light-controlled environment. An element that is absent from all of the components in a disc drive is also desirable because it can be readily detected by a spectrum analyzer. Depending on the disc drive, suitable elements might include radium, cesium, rubidium, or any of the other comparably heavy elements having a distinctive spectral signature (as detectable by conventional Auger analysis). To reduce the amount of an expensive marker impurity needed for effective evaluation, the dust is then mixed with about 50 grams of talc or other suitable carrier **125**. Preferably, the carrier is very coarse ground and has less than half of its particles small enough to enter the disc drive.

Next, the mixture is agitated so that some of it disperses into the air in an impurity chamber **135**. The chamber is configured adjacent a portion of the selected drive that includes a seal adjacent a "cavity" that operates at a below-ambient pressure in the disc drive's normal operation **140**. (Such a seal **346** is shown between an impurity chamber **330** and a cavity **350** in **Fig. 3**.)

Next, the impurity chamber is pressurized as necessary to create a pressure difference of at least 5 pounds per square inch, a pressure difference large enough to cause

air to flow steadily through the seal **150**. This flow rate is maintained throughout a 48 hour exposure period, reading steadily (for servo tracking, at least). At the same time, an average Bit Error Rate (BER) is repeatedly generated over a two day period or until a catastrophic failure, whichever comes first. Any significant changes are noted **155**, as they can be used as an indication that the marker impurity is detected within the disc drive. For a marker impurity including diamond dust as described above, little calibration work will be necessary because failures will typically be catastrophic. (In other words, the impurity threshold for such a marker will be "effectively zero" because even a few hundred such particles of suitable size entering the drive will very probably cause one to come between each head and its media surface, causing catastrophic failure.)

Note that where a catastrophic error occurs, the time to failure can be used to estimate how much of the marker impurity was present at an earlier time. Suppose, for example, that roughly 20 milligrams of the impurity will cause such a failure. If two devices take 4 hours and 10 hours to fail, it may be estimated that they had 5 mg and 2 mg after the first hour of exposure, respectively. If the one-hour threshold is set at 3 mg, and if none of the sample devices is permitted to fail, this test outcome will cause the original lot to fail. (Note that for a test of this type, it might be desirable to select modified devices as samples, ones that are similar to the remainder of the production lot but with no recirculation filter.)

For less aggressive types of marker impurities usable in the present invention, a modest amount of experimentation will be necessary to effectively determine what should constitute a "significant change" in the monitored performance indicator. One of ordinary skill would recognize such a change without experimentation in most cases, however, and in any case this will not hinder one of ordinary skill in practicing the present invention.

Turning now to **Fig. 2**, there is shown an even more detailed method **200** for using a single-device testing method like that of **Fig. 1**, comprising steps **205** through **270**. The method **100** is repeated for one or more additional selected devices **220**, in either sequential or simultaneous fashion. It is determined whether a monitored performance characteristic (e.g. BER) increases substantially for all selected devices **225**. If so, the production lot is re-



screened with a tightened leak rate specification **235**. Otherwise, the lot is deemed to have passed **230**.

In one of the disc drives under test, a new defect not present prior to the impurity chamber exposure will often be found. This may be manifested as a catastrophic error or as a "hard" (media) defect, for example. The disc drive is disassembled for analysis **240**. If the marker impurity included a luminescent dye **250**, the defect is examined visually under low light conditions **255**. In any case, a spectrum analyzer can then be used to determine whether an impurity is present at the site of the detected defect **260**. Note that the site is a failing transducer head, for catastrophic failures and many others.

After examining several new defects, it is possible to pareto their apparent causes. It is useful that the apparent cause for some new defects can be indicated as due to external dust or not, by use of the present method **200**, with a high degree of confidence. At step **265**, the percentage of the examined new defects found to contain the impurity is calculated and presented for this purpose.

Turning now to **Fig. 3**, there is shown a data handling device **300** having a housing with a sealed portion **340** comprising a porous filter or other imperfect seal **346** sealing two metal portions **344**. An impurity chamber **330** containing an airborne marker impurity **330** is at a pressure higher than that of the cavity **350** of the device. (Note that the "cavity" is the region just inside the sealed portion **340**, and that other portions of the device's interior may be at a higher pressure.) The pressure difference causes gas (and perhaps particles) to flow through the filter or seal **346**. Note that the marker impurity is selected so as to be substantially absent from all of the interior surfaces **352** of the device prior to the exposure of the device to the impurity chamber **330**.

**Fig. 4** shows a prototype apparatus suitable for performing a method like those of **Figs. 1&2**. An inlet **461** received filtered clean air through a pressure control valve **484** from an air compressor (not shown). Air then enters the mixing chamber **460**, in which it receives dust **429** that is agitated by an iron plug that is part of a conventional magnetic stirrer **440**. After mixing with the dust **429**, the air moves into the impurity chamber **480**. A recirculation fan **416** helps keep the dust suspended in the air in the impurity chamber **480**.

until the air leaves through exit filter **418**. As a result of this apparatus and of the communication/power connectors **414**, one or more disc drives **500** operate while almost completely immersed in dense airborne dust.

**Fig. 5** shows a partially exploded view of the disc drive **500** under test in **Fig. 4**. Disc drive **500** is a disc drive including base **502** to which various components are mounted. Top cover **523** cooperates with base **502** conventionally to form a sealed chamber. The components include a spindle motor which rotates data storage discs **510** at several thousand revolutions per minute. Information is written to and read from tracks **512** on discs **510** through the use of an actuator assembly **561**, which rotates during a seek operation about a bearing shaft assembly **530** positioned adjacent discs **510**. Actuator assembly **561** includes a plurality of actuator arms which extend above and below each disc **510**, with one or more flexures extending from each of the actuator arms. Mounted at the distal end of each of the flexures is a transducer head **534** which includes an air-bearing slider enabling transducer head **534** to fly in close proximity above the corresponding surface of associated disc **510**. Because of the low fly height and fine track widths, particles are removed from the chamber whenever the drive operates by use of a recirculation filter **571**. As a response to damage by large particles, as detected by the present invention, one might desire to increase the density and reduce the porosity of the recirculation filter **571**.

Servo and user data travels through transducer head **534** and flex cable **580** to control circuitry on controller board **506**. Flex cable **580** maintains an electrical connection by flexing as transducer heads **534** traverse tracks **512** along their respective radial paths **538**. By "radial," it is meant that path **538** is substantially aligned with a radius of the disc(s) **510**, although their directions may be offset from a perfectly radial direction by up to about 20 degrees due to head skew, as is understood in the art.

During a seek operation, the overall track position of transducer heads **534** is controlled through the use of a voice coil motor (VCM), which typically includes a coil **522** fixedly attached to actuator assembly **561**, as well as one or more permanent magnets **520** which establish a magnetic field in which coil **522** is immersed. The controlled application of current to coil **522** causes magnetic interaction between permanent magnets **520** and coil

522 so that coil 522 moves. As coil 522 moves, actuator assembly 561 pivots about bearing shaft assembly 530 and transducer heads 534 are caused to move across the surfaces of discs 561 between the inner diameter and outer diameter of the disc(s) 561. Fine control of the position of head 534 is optionally made with a microactuator (not shown) that operates  
5 between the head 534 and the actuator arm.

As will be appreciated by those of skill in the art, several portions of the chamber formed by baseplate 502 and cover 523 are imperfectly sealed. This provides many gaps through which particles having a length larger than the width of tracks 512 might enter. Track densities can be 100000 tracks per inch or higher in today's disc drives, making them  
10 vulnerable to exceedingly small particles that can come from any of several sources within the chamber or from the outside. The present invention provides a new and useful way to evaluate a new configuration and to help eliminate a reliability concern.

Alternatively characterized, a first embodiment of the present invention is a method (such as 100) to evaluate a multiplicity of data handling devices (such as 500) each having a sealed chamber (such as 300) with several interior surfaces (such as 352). At least one of the devices is selected (such as by step 110 or arbitrarily). An impurity chamber (such as 330,480) is provided (such as by step 135) containing thousands of dispersed gas-borne particles each containing a marker impurity that is substantially absent from all of the interior surfaces of the selected device(s). Preferably, a high quality marker impurity is  
20 provided in a mixture containing a carrier impurity generally comprising larger particles of a hardness similar to those of the marker impurity. When the mixture is agitated, some of the marker impurity disperses into the gas (such as by step 135) of the chamber.

A sealed portion of the selected data handling device(s) is exposed to the impurity chamber (such as by step 140). During this time, the cavity is maintained at a lower  
25 pressure than that of the impurity chamber (such as by step 150). The multiplicity of data handling devices is evaluated (such as by steps 225,230,235,265) based on an indication of whether the marker impurity is present in an amount exceeding a predetermined threshold (such as the "any significant change" indication of step 155).

In a second embodiment, the multiplicity of data handling devices can each store data in thousands of tracks (such as 512) written therein. The tracks define a median width  $W$ . Of those airborne particles of the marker impurity having a length greater than  $W$ , in this embodiment, at least 5% of them have a length less than  $10W$  (such as by step 120).

5 This reduces an amount of the marker impurity needed to perform an effective evaluation.

In a third embodiment, the device selection is performed based on an outcome of the leak-testing step (such as by step 110). A range of marginal leak rates is identified that is broad enough so as to include at least one leak rate corresponding to one of the multiplicity of data handling devices. The range is then used to identify a subset of the data handling  
10 devices such that each identified device has a leak rate within the range, the identified device(s) being the selected device(s).

In a fourth embodiment, the sealed housing portion (such as 340) includes a porous filter (such as 346) positioned between the impurity chamber and the cavity (such as by step 140). The cavity, a localized portion of a chamber of a data handling device, is optionally constructed so that operating the device causes it to be partially evacuated. This causes the gas in the impurity chamber to flow (such as by step 150) from the impurity chamber (such as 330) through the porous filter into the cavity (such as 350). This flow, which can be as small as 1-10 cc's per day or smaller, is preferably sustained for a period of at least one day or until a catastrophic failure occurs (such as by step 155).

20 In a fifth embodiment, the marker impurity essentially consists of an ingredient selected so as to be at least 10% harder than a data storage surface of the tested device (such as by step 120) so that one of the airborne particles can damage and become lodged into the data storage surface (such as by step 260). With a very hard marker impurity such as molybdenum or diamond of suitable size, this damage will be significant enough to cause a  
25 dramatic operational change so that any of several indicators will change dramatically even a miniscule amount of the particulate impurity enters the device. Preferably, one or more test devices are exposed to the impurity, and an indicator is selected so as to evaluate the production lot as a failure only if the amount of the detected impurity inside the devices exceeds a predetermined threshold that is effectively zero (such as by step 235).

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In a sixth embodiment, the marker impurity includes a luminescent material, and in which the examining step (d1) includes a step of maintaining a region adjacent the media surface at a lighting level of less than 3 hectolux to detect whether the luminescent material is present (such as by step 255). With suitable light and magnification, this can be performed by performed by viewing or photographing the media surface to detect whether the dye is present. Additionally, the chemical content of a media defect can be analyzed with a spectrum analyzer (such as by step 260) to verify that the defect contains some of the marker impurity.

All of the structures and methods described above will be understood to one of ordinary skill in the art, and would enable the practice of the present invention without undue experimentation. It is to be understood that even though numerous characteristics and advantages of various embodiments of the present invention have been set forth in the foregoing description, together with details of the structure and function of various embodiments of the invention, this disclosure is illustrative only. Changes may be made in the details, especially in matters of structure and arrangement of parts within the principles of the present invention to the full extent indicated by the broad general meaning of the terms in which the appended claims are expressed. For example, particles each containing a few ingredients can be used rather than pure particles, without departing from the scope and spirit of the present invention. In addition, although the preferred embodiments described herein are largely directed to disc drives, it will be appreciated by those skilled in the art that many teachings of the present invention can be applied to other dust-sensitive data handling devices such as tape drives without departing from the scope and spirit of the present invention.